Attorney's Docket No. 6317P003

Patent

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Gilad Almogy et al.

Application No.: Unassigned

Filed: Herewith

For: SYSTEM AND METHOD FOR DEFECT LOCALIZATION ON ELECTRICAL TEST

STRUCTURES

Examiner:	N/A	

Art Group: Unassigned

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on April 1, 2005 Date of Deposit	
Jennifer L. Stewart Name of Person Mailing Correspondence	
Senature Allos	

PRELIMINARY AMENDMENT

Sir:

Please enter the following preliminary amendment for the present patent application.